

<b>Notice of References Cited</b>	Application/Control No. 10/787,496	Applicant(s)/Patent Under Reexamination AOKI ET AL.	
	Examiner Thi Q. Le	Art Unit 2613	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,778,118 A	07-1998	Sridhar, Balakrishnan	385/24
*	B	US-6,032,041 A	02-2000	Wainfan et al.	455/427
*	C	US-2002/0101632 A1	08-2002	Meckler, Milton	359/115
*	D	US-2003/0142980 A1	07-2003	Baba, Teruyuki	398/56
*	E	US-2004/0252688 A1	12-2004	May et al.	370/389
*	F	US-2005/0111495 A1	05-2005	Gumaste et al.	370/535
*	G	US-6,889,007 B1	05-2005	Wang et al.	398/79
*	H	US-7,072,584 B1	07-2006	Lichtman et al.	398/59
*	I	US-2006/0153563 A1	07-2006	Feuer et al.	398/045
*	J	US-7,088,920 B2	08-2006	Krishnaswamy et al.	398/58
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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